

<b>Notice of References Cited</b>	Application/Control No. 10/581,829		Applicant(s)/Patent Under Reexamination BEZENCON ET AL.	
	Examiner Jeffrey H. Murray		Art Unit 1609	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2007/0142363	06-2007	Bezencon et al.	514/220
*	C	US-2007/0135406	06-2007	Bezencon et al.	514/211.09
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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	U	Whitworth et. al.; Expert Opinion; 2003; 8(2), p. 377-388.
	V	Chawla et. al.; CRIPS Vol: 5, No.1, p.9-12.
	W	Newman et. al.; DDT Vol. 8, No. 19, p. 898-905.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.